

Innovative Service Around the Globe

# DATA SHEET SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS Automotive grade HiCap X7R/X7S

4 V TO 100 V I μF to 10 μF RoHS compliant & Halogen Free



## YAGEO

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Surface-Mount Ceramic Multilayer Capacitors Automotive Grade HiCap X7R/X7S 4 V to 100 V

#### <u>SCOPE</u>

This specification describes Automotive grade X7R/X7S series chip capacitors with lead-free terminations and used for automotive equipments.

#### APPLICATIONS

All general purpose applications under normal operation and usage conditions for automotive equipments.

#### **FEATURES**

- AEC-Q200 qualified
- MSL class: MSL I
- AC series soldering is compliant with J-STD-020D
- High component and equipment reliability
- The capacitors are 100% performed by automatic optical inspection prior to taping.

#### ORDERING INFORMATION - GLOBAL PART NUMBER

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

#### **GLOBAL PART NUMBER**

AC <u>XXXX</u> <u>X</u> <u>X</u> <u>XXX</u> <u>X</u> B <u>X</u> <u>XXX</u> (1) (2) (3) (4) (5) (6) (7)

#### (I) SIZE - INCH BASED (METRIC)

0201 (0603) / 0402 (1005) / 0603 (1608) / 0805 (2012) / 1206 (3216)/ 1210 (3225) /1812 (4532)

#### (2) TOLERANCE

 $J = \pm 5\%$ K = ±10%

M= ±20%

Capacitance tolerance  $\pm 5\%$  doesn't available for X7R full product range, please contact local sales before order

#### (3) PACKING STYLE (SEE TABLE. 8 FOR DETAIL)

- R = Paper/PE taping reel; Reel 7 inch
- K = Blister taping reel; Reel 7 inch
- P = Paper/PE taping reel; Reel 13 inch
- F = Blister taping reel; Reel 13 inch

#### (4) TC MATERIAL

 $X7R: -55 \degree C \text{ to } + 125 \degree C (\Delta C/C \pm 15\%)$ 

X7S : -55 °C to +125 °C ( $\Delta$ C/C ± 22%)

#### (5) RATED VOLTAGE

4	= 4 V	
5	= 6.3 V	
6	= 10 V	
7	= 16 V	
8	= 25 V	
G	= 35 V	
9	= 50 V	

 $0 = 100 \vee$ 

#### (6) PROCESS

B = X7R/X7S

#### (7) CAPACITANCE VALUE

2 significant digits + number of zeros

The 3rd digit signifies the multiplying factor, and letter R is decimal point Example:  $121 = 12 \times 10^{1} = 120 \text{ pF}$ 

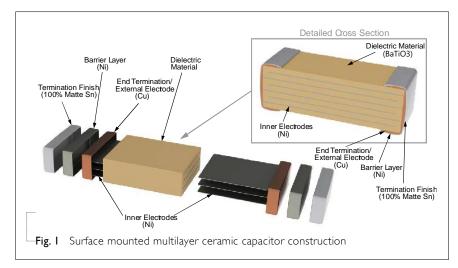
#### **CONSTRUCTION**

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (Matte Sn). The terminations are leadfree. A cross section of the structure is shown in Fig.1.

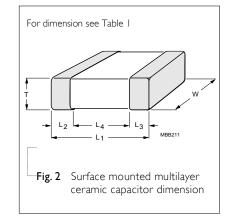
#### **DIMENSION**

Table I For outlines see fig. 2



	YPE L <sub>I</sub> (mm) W (mm) T (MM)			L <sub>2</sub> / L <sub>3</sub> (mm)		L <sub>4</sub> (mm)
TYPE	$L_1$ (mm)	nm) W (mm) T (MM)		min.	max.	min.
0201	0.6 ±0.03	0.3±0.03	0.3±0.03	0.10	0.20	0.20
0402	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15	0.35	0.30
0603	1.6 ±0.10	0.8 ±0.10	0.8 ±0.10	0.20	0.50	0.60
	2.0 ±0.10	1.25 ±0.10	0.6 ±0.10			
0805	201020		0.85 ±0.10	0.25	0.75	0.70
	2.0 ±0.20	1.25 ±0.20	1.25 ±0.20			
	22.015		0.6 ±0.10			
	3.2 ±0.15	1.6 ±0.15	0.85 ±0.10			
1207			1.15 ± 0.10	0.05	0.75	
1206	3.2 ±0.30	1.6 ±0.20	1.25 ±0.20	0.25	0.75	1.50
			1.6 ±0.20			
	3.2 ±0.30	1.6 ±0.30	1.6 ±0.30			
	3.2 ±0.20	2.5 ±0.20	0.85 ±0.10			
			1.25 ±0.20			
1210	3.2 ±0.30	2.5 ±0.20	1.6 ±0.20	0.25	0.75	1.50
			2.0 ±0.20			
	3.2 ±0.40	2.5 ±0.30	2.5 ±0.20			
1808	4.5 ±0.40	2.0 ±0.30	1.25 ±0.20	0.25	0.75	2.20
			0.85 ±0.10			
1812	4.5 ±0.40	3.2 ±0.30	1.25 ±0.20	0.25	0.75	2.20
			1.6 ±0.20			

#### OUTLINES



### CAPACITANCE RANGE & THICKNESS FOR X7R

Table 2 Sizes from 0603	to 0805	
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,	CAP.	0603				0805					
		6.3V	10V	16 V	25 V	6.3 V	10 V	16 V	25 V	35 V	50 V
	ΙμF	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	-	1.25±0.2	1.25±0.2	1.25±0.2	-	1.25±0.2
	2.2 uF						1.25±0.2	I.25±0.2	1.25±0.2	1.25±0.2	
	4.7 uF						1.25±0.2	1.25±0.2			
	10 uF					1.25±0.2	1.25±0.2				

Table 3 Sizes 1206

## CAP. 1206

	6.3 V	10V	16V	25V	50 V	100 V
ΙμF		1.15±0.10	1.15±0.10	1.60±0.2	1.60±0.2	1.60±0.2
2.2 µF			1.60±0.2	1.60±0.2	1.60±0.2	1.60±0.2
4.7 uF	1.60±0.2	1.60±0.2	1.60±0.2			
I0 uF						

Table 4	Sizes	1210 to	1812
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C	CAP.	1210			1812	
		25 V	50V	100 V	50V	100V
	ΙμF	1.25±0.20	1.25±0.20	2.0±0.2	1.60±0.2	1.60±0.2
	2.2 µF		2.0±0.2	2.0±0.2		
	4.7 µF	2.5±0.2	2.5±0.2			

#### NOTE

I. Values in shaded cells indicate thickness class in mm

2. Capacitance value of non E3 series is on request

#### **ELECTRICAL CHARACTERISTICS**

#### X7R DIELECTRIC CAPACITORS; NI/SIN TERMINATIONS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

- Temperature: 15 °C to 35 °C
- Relative humidity: 25% to 75%
- Air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

#### RATED VOLTAGE AND CAPACITANCE

Table 5					
SIZE	RATED	CAPACITANCE	5.5		
			D.F.	RC @ 25 °C	RC @ 125 °C
CODE	(VDC)	(µF)	E 00/	(Ω•F)	(Ω•F)
	6.3	1.0	5.0%	500	50
0603	10	1.0	5.0%	500	50
	16 25	1.0	7.5% 7.5%	100	5
	10	1.0	7.5% 5.0%	500	50
	10	1.0 1.0	5.0%	500	50
	25	1.0	5.0%	500	50
	50	1.0	5.0%	500	<u> </u>
	10	2,2	5.0%	100	10
	10	2.2	5.0%	100	10
0805	25	2.2	5.0%	100	10
	35	2.2	5.0%	100	10
	10	4.7	10.0%	100	10
	16	4.7	10.0%	100	10
	6.3	10.0	10.0%	100	10
	10	10.0	10.0%	100	10
	10	1.0	3.5%	500	10
	25	1.0	3.5%	500	10
	50	1.0	5.0%	500	10
	100	1.0	5.0%	500	10
	16	2.2	5.0%	500	50
1206	25	2.2	5.0%	500	50
	50	2.2	5.0%	500	10
	100	2.2	5.0%	500	10
	6.3	4.7	10.0%	50	5
	10	4.7	10.0%	50	5
	16	4.7	10.0%	50	5
	25	1.0	2.5%	500	50
	50	1.0	2.5%	500	50
	100	1.0	5.0%	500	50
1210	50	2.2	5.0%	500	50
	100	2.2	5.0%	500	50
	25	4.7	10.0%	500	10
	50	4.7	10.0%	500	10
1812	50	1.0	2.5%	500	50
1012	100	1.0	2.5%	500	50

#### SOLDERING RECOMMENDATION

Table 6

SOLDERING METHOD	SIZE 0201	0402	0603	0805	1206	≥  2 0
Reflow	Reflow only	≥ 0.1 µF	≥ 1.0 µF	≥ 2.2 µF	≥ 4.7 µF	Reflow only
Reflow/Wave		< 0.1 µF	< 1.0 µF	< 2.2 µF	< 4.7 µF	

#### SOLDERING CONDITIONS

The lead free MLCCs are able to stand the reflow soldering conditions as below:

- Temperature: above 220 °C
- Endurance: 95 to 120 seconds
- Cycles: 3 times

The test of "soldering heat resistance" is carried out in accordance with the schedule of "MIL-STD-202G-method 210F", "The robust construction of chip capacitors allows them to be completely immersed in a solder bath of 260 °C for 10 seconds". Therefore, it is possible to mount MLCCs on one side of a PCB and other discrete components on the reverse (mixed PCBs). Surface Mount Capacitors are tested for solderability at 245 °C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds.

#### TESTS AND REQUIREMENTS

Table 7	Test procedures and	d requirements
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NO	AEC-Q200 TEST	TEST METHOD	REQUIREMENTS
		Unpowered ; 1000hours @ T=150 °C Measurement at 24±2 hours after test conclusion.	No visual damage
			$\Delta$ C/C X7R: Within ±10%
Ι	High Temperature Exposure		D.F.: within initial specified value
			IR: within initial specified value
		Preconditioning; 150 +0/–10 °C for 1 hour, then keep for	No visual damage
2	Temperature Cycling	$24 \pm 1$ hours at room temperature 1000 cycles with following detail:	ΔC/C X7R: ±10%
2		30 minutes at lower category temperature 30 minutes at upper category temperature	D.F. meet initial specified value
		Recovery time 24 ±2 hours	IR meet initial specified value
3	Destructive Physical Analysis	Electrical test not required.	

		T=24 hrs/per cycle; 10 continuous cycles unpowered.	No visual damage
		Measurement at 24 ±2 hours after test condition.	ΔC/C X7R: ±15% D.F. Within initial specified value
4	Moisture Resistance	PRIOR TO FIRST CYCLE STEP 1 STEP 2 STEP 3 STEP 4 STEP UNLESS OTHERMISE	END OF FINAL CYI MEASUREMENTS AS SPECIFIED IN 3.6 F APPLICABLE) F APPLICABLE) HED A MINIMUM OF LES. HUNDITY IS RING
5	Biased Humidity	<ol> <li>Preconditioning: 150 +0/-10 °C /1 hour, then keep for 24 ±1 hour at room temp</li> <li>Initial measure: Spec. refer to initial spec. C. D. I.R. Note: Series with 100 KΩ</li> <li>Test condition: 85 °C, 85% R.H. connected with 100 KΩ resistor, applied 1.5V/U<sub>r</sub> (no more than 630V) for 1,000 hours.</li> <li>Recovery: X7R/X7S: 24 ±2 hours</li> <li>Final measure: C. D. I.R.</li> </ol>	No visual damage after recovery ΔC/C X7R/X7S: ±15% D.F. X7R/X7S: Less than 200% of initial spec.

		I. Preconditioning:	No visual damage
		I50 +0/-10 °C /I hour, then keep for 24 ±1 hour at room temp 2. Initial measure:	ΔC/C X7R/X7S: ±15%
	High Temperature Operational Life	Spec: refer to initial spec C, D, IR 3. Endurance test: Temperature: 125 °C	D.F. Less than 200% of initial spec.
6		<ul> <li>Specified stress voltage applied for 1,000 hours: Applied 150% × Ur.</li> <li>Recovery time: 24 ±2 hours</li> <li>Final measure: C, D, IR Note: If the capacitance value is less than the minimum value permitted, then after the other measurements have been made the capacitor shall be preconditioned according to "IEC 60384 4.1" and then the requirement shall be met.</li> </ul>	IR The insulation resistance shall be greater than 10% of initial spec.
7	External Visual	Any applicable method using × 10 magnification	In accordance with specification
8	Physical Dimension	Verify physical dimensions to the applicable device specification.	In accordance with specification
9	Mechanical Shock	Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks) Peak value: 1,500 g's Duration: 0.5 ms Velocity change: 15.4 ft/s Waveform: Half-sin	$\begin{array}{l} \Delta C/C \\ \times 7 R/X7S: \pm 10\% \\ \\ \text{D.F.} \\ \text{Within initial specified value} \\ \\ \text{IR} \\ \text{Within initial specified value} \end{array}$
10	Vibration	5 g's for 20 minutes, 12 cycles each of 3 orientations. Test from 10-2000 Hz.	ΔC/C X7R/X7S: ±10% D.F: meet initial specified value
		Precondition: $150 \pm 0/-10$ °C for 1 hour, then keep for $24 \pm 1$ hours at room temperature Preheating: for size $\leq 1206$ : $120$ °C to $150$ °C for 1 minute Preheating: for size $>1206$ : $100$ °C to $120$ °C for 1 minute and	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned
	Resistance to Soldering Heat	170 °C to 200 °C for 1 minute Solder bath temperature: 260±5 °C	ΔC/C X7R/X7S: ±10%
		Dipping time: 10±0.5 seconds Recovery time: 24±2 hours	D.F. within initial specified value
			IR within initial specified value

		I. Preconditioning: I50 +0/-10 °C /I hour, then keep for 24±1 hour at room	No visual damage					
		temp	ΔC/C					
		2. Initial measure:	X7R/X7S: ±15%					
			X/IVX/3. ±13%					
		Spec: refer to initial spec C, D, IR						
12	Thermal Shock	3. Rapid change of temperature test:	D.F: meet initial specified value					
		-55 °C to +125 °C; 300 cycles						
		15 minutes at -55°C ;	IR meet initial specified value					
		15 minutes at 125 °C						
		4. Recovery time:						
		X7R/X7S 24±2 hours						
		5. Final measure: C, D, IR						
		Per AEC-Q200-002	A component passes a voltage					
			level if all components stressed					
			at that voltage level pass.					
			YNM0053-1					
		6 kV DC						
		FAIL PASS						
		2 kV DC	12 kV AD					
		FAIL PASS	FAIL PASS					
13	ESD	1 kV 4 kV DC DC						
		DC     DC     DC       FAIL     PASS     FAIL     PASS	S FAIL PASS					
		<b>† † † † † † † † † †</b>	8 kV 12 kV 25 kV					
		FAIL PASS	DC AD AD FAIL PASS					
		< 500 V DC DC	16 kV 25 kV AD AD					
		Note: Classify the components according to the highest ESD voltage	level survived during ESD testing.					
		<b>Fig. 4</b> Passive component HBM ESD test flow diagram						
		(DC = Direct Contact Discharge, AD = Air Discharge)	)					
			The solder should cover over					
		I. Preheat at 155°C for 4 hours. After preheating, immerse the	95% of the critical area of each					
		capacitor in a solution of ethanol and rosin (25% rosin in	termination.					
		weight proportion). Immerse in eutectic solder solution for						
		5+0/-0.5 seconds at 235±5°C.						
		2. Should be placed into steam aging for 8 hours $\pm$ 15 minutes.						
		After preheating, immerse the capacitor in a solution of						
14	Solderability	ethanol and rosin (25% rosin in weight proportion).						
ΙT	JUILEI ADIIILY	Immerse in eutectic solder solution for 5+0/-0.5 seconds at						
		235±5°C.						
		3. Should be placed into steam aging for 8 hours±15 minutes.						
		After preheating, immerse the capacitor in a solution of						
		Ethanol and rosin (25% rosin in weight proportion).						
		Immerse in eutectic solder solution for 120±5 seconds at						
		$260\pm5$ °C.						

		Capacitance	X7R/X7S: At 25 °C, 24 hours after annealing f = 1±0.1 KHz, measuring at voltage 1±0.2 V <sub>ms</sub> at 25 °C	Within specified tolerance
		Dissipation Factor (D.F.)	X7R/X7S: At 25 °C, 24 hours after annealing f = 1±0.1 KHz, measuring at voltage 1±0.2 V <sub>rms</sub> at 25 °C	In accordance with specification on Table 5
		Insulation Resistance (I.R.)	At $U_r$ (DC) for I minute	In accordance with specification on Table 5
			Capacitance shall be measured by the steps shown in the following table. The capacitance change should be measured after 5 min at each specified temperature stage. Step Temperature(°C)	ΔC/C X7R: ±15% X7S: ± 22%
15	Electrical Characterization	Temperature	a25±2bLower temperature±3°Cc25±2dUpper Temperature±2°Ce25±2	
			X7R Capacitance Change shall be calculated from the formula as below $\Delta C = \frac{C2 - CI}{CI} \times 100\%$ CI: Capacitance at step c C2: Capacitance at step b or d	
		Voltage Proof	<ol> <li>Specified stress voltage applied for 1~5 seconds</li> <li>Ur ≤ 100 V: series applied 2.5 Ur</li> <li>Charge/Discharge current is less than 50 mA</li> </ol>	No breakdown or flashover

		Part mounted on a 100mm × 40mm FR4 PCB board, which is	No visu	al dama	age	
		<ul> <li>1.6±0.2 mm thick and has a layer-thickness 35μm±10 μm.</li> <li>Part should be mounted using the following soldering reflow profile.</li> <li>Conditions:</li> <li>X7R/X7S:</li> </ul>	ΔC/C X7R/X7S: ±10%			
		Bending 2 mm at a rate of 1 mm/s, radius jig 340 mm		Dimen	sion(m	ım)
		Tichin	Туре	а	b	c
		Test Substrate:	0201	0.3	0.9	0.3
16	Board Flex	←	0402	0.4	1.5	0.5
			0603	1.0	3.0	1.2
			0805	1.2	4.0	1.65
			1206	2.2	5.0	1.65
			1210	2.2	5.0	2.0
		l <del>∢t</del> unit: mm	1808	3.5	7.0	3.7
		With the component pounted on a DCD obtained with the	Magaifia		fJOV	
17	Terminal Strength	<ul> <li>With the component mounted on a PCB obtained with the device to be tested, apply a 17.7N (1.8Kg) force to the side of a device being tested.</li> <li>This force shall be applied for 60+1 seconds.</li> <li>Also the force shall be applied gradually as not to apply a shock to the component being tested.</li> <li>* Apply 2N force for 0402 size.</li> <li>* Apply 1N force for 0201 size.</li> <li>Magnification of 20X or greating may be employed for inspection of the mechanical integrity of the device body, terminals and body/terminal junction.</li> <li>Before, during and after the test, the device shall comply with all electrical requirement stated in this specification.</li> </ul>				
18	Beam Load Test	Place the part in the beam load fixture. Apply a force until the part breaks or the minimum acceptable force level required in the user specification(s) is attained.       ≤ 0805         Thickness > 0.5mm: 1       Thickness > 0.5mm: 1         Thickness ≤ 0.5mm: 1       Thickness ≤ 0.5mm: 1				

## THICKNESS CLASSES AND PACKING QUANTITY

Table 8

	THICKNESS	PACKING CODE			QUANTITY PER REEL					
SIZE CODE	CLASSIFICATION	FACINI	NG CODE	TAPE WIDTH	Ø180 MN	1 / 7 INCH	Ø330 MI	1 / 13 INCH		
	CLASSIFICATION	7 INCH	13 INCH		Paper	Blister	Paper	Blister		
0201	0.3 ±0.03 mm	R	Р	8 mm	15,000		50,000			
0402	0.5 ±0.05 mm	R	Р	8 mm	10,000		50,000			
0603	0.8 ±0.1 mm	R	Р	8 mm	4,000		15,000			
	0.6 ±0.1 mm	R	Р	8 mm	4,000		20,000			
0805	0.85 ±0.1 mm	R	Р	8 mm	4,000		15,000			
	1.25 ±0.2 mm	К	F	8 mm		3,000		10,000		
	0.6 ±0.1 mm	R	Р	8 mm	4,000		20,000			
	0.85 ±0.1 mm	R	Р	8 mm	4,000		15,000			
1206	1.0/1.15 ±0.1 mm	К	F	8 mm		3,000		10,000		
	1.25 ±0.2 mm	К	F	8 mm		3,000		10,000		
	1.60 ±0.2 mm	К	F	8 mm		2,000		8,000		
	0.85 ±0.1 mm	К	F	8 mm		4,000		10,000		
	1.15 ±0.1 mm	К	F	8 mm		3,000		10,000		
1210	1.25 ±0.2 mm	К	F	8 mm		3,000		10,000		
	2.0 ±0.2 mm	К		8 mm		2,000				
	2.5 ±0.2 mm	К		8 mm		1,000				
	0.6 / 0.85±0.1 mm	К		l2 mm		2,000				
1010	1.15±0.1 mm	К		l2 mm		1,000				
1812	1.25±0.2 mm	К		l2 mm		1,000				
	I.6 ±0.2 mm	К		l2 mm		2,000				

## PAPER/PE TAPE SPECIFICATION

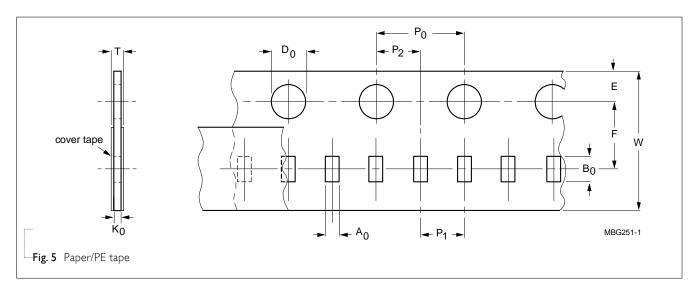


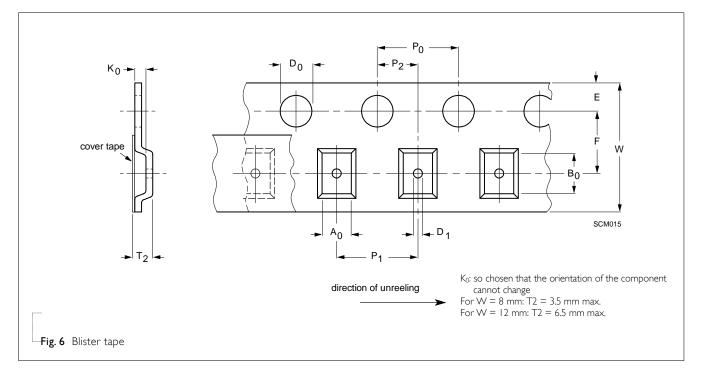
Table 9	Dimensions of paper/PE tape for relevant chip size; see Fig.5
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SIZE	SYMBOL	SYMBOL Unit: mm											
CODE	A0	B0	W	E	F	P0 (I)	PI	P2	ØD0	К0	Т		
0201	0.39 ± 0.06	0.70 ± 0.06	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.05	2.0 ± 0.05	2.0 ± 0.05	1.55 ± 0.03	0.38 ± 0.05	(0.47 / 0.55)±0.10		
0402	0.70 ± 0.15	1.21 ± 0.12	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.05	2.0 ± 0.05	2.0 ± 0.05	1.50 +0.1 /-0	(0.75 / 0.60)±0.10	(0.85 / 0.70)±0.10		
0603	1.05 ± 0.14	1.86 ± 0.13	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 /-0	(1.05 / 0.95 / 0.75)±0.10	(1.15 / 1.05 / 0.85)±0.10		
0805	1.50 ± 0.15	2.26 ± 0.20	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 /-0	(1.05 / 0.95 / 0.75)±0.10	(1.15 / 1.05 / 0.85)±0.10		
1206	1.90 ± 0.15	3.50 ± 0.20	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 /-0	(0.95 / 0.75)±0.10	(1.05 / 0.85)± 0.10		

#### NOTE

 $1.P_0$  pitch tolerance over any 10 pitches is  $\pm 0.2 \text{ mm}$ 

## **BLISTER TAPE SPECIFICATION**



#### Table 10 Dimensions of blister tape for relevant chip size; see Fig.6

	SYMBOL												Un	iit: mm		
size code	A <sub>0</sub>		B <sub>0</sub>		K <sub>0</sub>		W	E	F	ØD <sub>0</sub>	ØDI	P <sub>0</sub> <sup>(2)</sup>	Pı	P <sub>2</sub>		Т2
	Min.	Max.	Min.	Max.	Min.	Max.					Min.				Min.	Max,
0805	1.29	1.65	2.09	2.60	1.25	1.62	8.1 ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	+0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.30	1.67
1206	1.65	2.12	3.30	3.75	1.22	2.15	8.1 ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	+0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.27	2.20
1210	2.55	3.02	3.31	3.88	0.97	2.92	8.1 ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	+0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.02	2.97
1808	2.05	2.55	4.80	5.45	1.30	2.45	2,  ±0.20	1.75 ±0.1	5.5 ±0.05	1.5 +0.1/-0.0	1.5 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	I.35	2.50
1812	3.35	3.75	4.70	5.33	0.70	2.40	2,  ±0.20	1.75 ±0.1	5.5 ±0.05	1.5 +0.1/-0.0	1.5 +0.1/-0.0	4.0 ±0.10	8.0 ±0.10	2.0 ±0.05	0.75	2.45

#### NOTE

I. Typical capacitor displacement in pocket

2.  $P_0$  pitch tolerance over any 10 pitches is  $\pm 0.2$  mm

## **REEL SPECIFICATION**

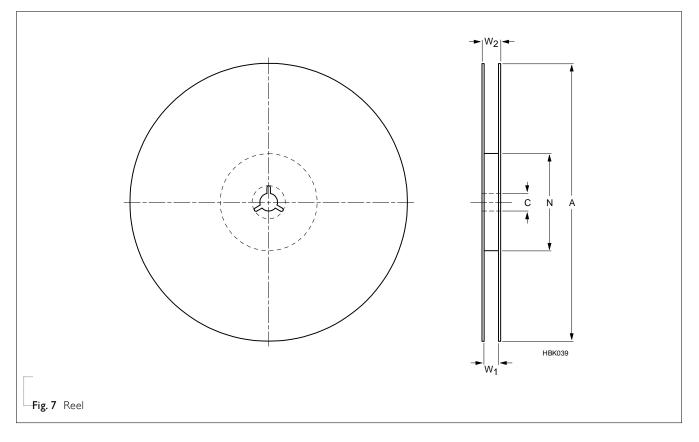


Table I I Reel dimensions; see Fig.7

	SYMBOL				Unit: mm	
TAPE WIDTH	A	N	С	W	W <sub>2max.</sub>	
8 (Ø178 mm/7")	178 ±1.0	60 ±1.0	3 +0.50/-0.20	9.4 ±1.5	14.4	
8 (Ø330 mm/13")	330 ±1.0	100 ±1.0	13 +0.50/-0.20	9.0 ±0.2	4.4	
12 (Ø178 mm/7")	178 ±1.0	60 ±1.0	3 +0.50/-0.20	3.4 ±1.5	18.4	

## **PROPERTIES OF REEL**

Material: polystyrene Surface resistance:  $<10^{10}$  X/sq.

#### MOUNTING

#### SOLDER REPAIRS

Conventional solder repairs are carried out with a soldering iron as shown as Tab. 13. The tip of the soldering iron should not directly touch the chip component to avoid thermal shock on the interface between termination and body during mounting, repairing or de-mounting processes. Ensure the termination solder has melted before removing the chip component.

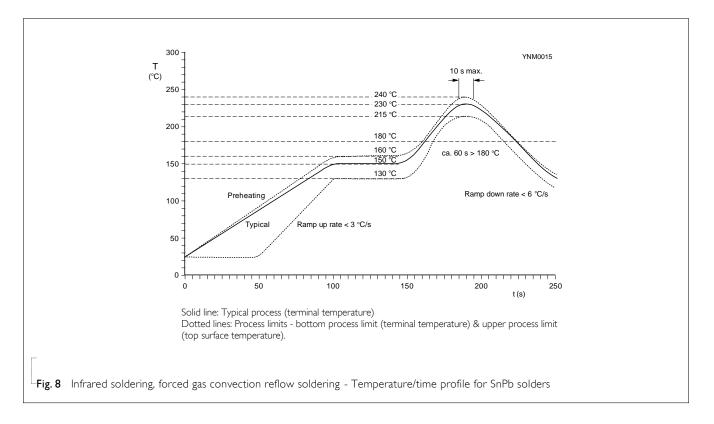
- Table 12 Recommended soldering iron condition

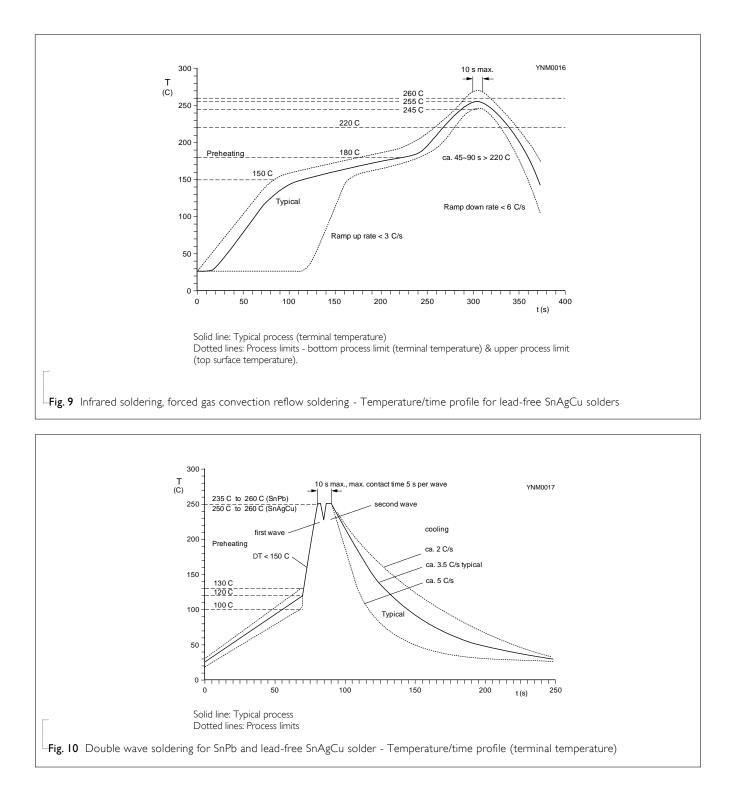
SIZE	Temp(°C)	DURATION (SEC.)	PREHEATING TEMP(°C)	ATMOSPHERE
0201/0402/0603/0805/1206	350 max.	3 max.	150 min.	air
1210/1808/1812/2220	280 max.	3 max.	150 min.	air

#### SOLDERING CONDITIONS

For normal use the capacitors may be mounted on printed-circuit boards or ceramic substrates by applying wave soldering, reflow soldering or conductive adhesive in accordance with *IEC 61760-1* (Standard method for the specification of surface mounting components). For advised soldering profiles see Figs 8, 9, 10. An improper combination of soldering, substrate and chip size can lead to a damaging of the component. The

An improper combination of soldering, substrate and chip size can lead to a damaging of the component. The risk increases with the chip size and with temperature fluctuations (>100  $^{\circ}$ C).





#### FOOTPRINT DIMENSIONS

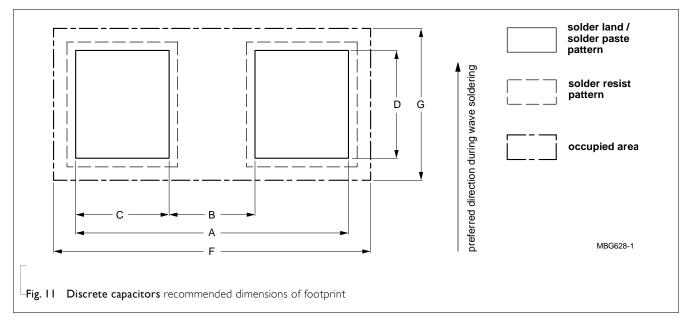


Table 13 Reflow soldering; for footprint dimensions see Fig. I I

SIZE	FOOTPRIN		Unit: mm				
CODE	А	В	С	D	F	G	Processing remarks
0201	0.8 ±0.20	0.25 ±0.05	0.28 ±0.07	0.3 ±0.10			
0402	1.5 ±0.15	0.5 ±0.15	0.5 ±0.15	0.5 ±0.15	1.75 ±0.15	0.95 ±0.15	
0603	2.3 ±0.15	0.7 ±0.15	0.8 ±0.15	0.9 ±0.15	2.7 ±0.15	1.5 ±0.15	
0603	2.3 ±0.25	0.5 ±0.25	0.9 ±0.25	0.9 ±0.25	2.7 ±0.25	1.5 ±0.25	IR or hot plate soldering
0805	2.8 ±0.25	0.9 ±0.25	0.95 ±0.25	1.4 ±0.25	3.2 ±0.25	2.1 ±0.25	_
1206	4.0 ±0.25	2.0 ±0.25	1.0 ±0.25	1.8 ±0.25	4.4 ±0.25	2.5 ±0.25	_
1210	4.0 ±0.25	2.0 ±0.25	1.0 ±0.25	2.7 ±0.25	4.4 ±0.25	3.4 ±0.25	
1808	5.4 ±0.25	3.3 ±0.25	1.05 ±0.25	2.3 ±0.25	5.8 ±0.25	2.9 ±0.25	_
1812	5.4 ±0.25	3.3 ±0.25	1.05 ±0.25	3.5 ±0.25	5.8 ±0.25	4.1 ±0.25	Ceramic substrate only
2220	6.6 ±0.25	4.5 ±0.25	1.05 ±0.25	5.3 ±0.25	7.0 ±0.25	5.9 ±0.25	

## <u>REVISION HISTORY</u>

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 0	Aug. 31, 2022	-	- New
Version I	Sep. 15, 2022	-	- Add 0805/X7R/10V/10uF

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## Surface-Mount Ceramic Multilayer Capacitors

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